GKS-075 319 120 A 1500

Item GKS-075-0669



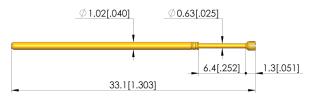


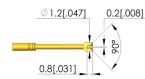
- Well-established test probes for contacting PCBs
- For optimal contact to the test points (e.g. pads, vias, and pins), various tip styles with various diameters and finishes are available.
- · Various spring forces available as well as versions with stainless steel springs suitable for high temperatures
- Used for setting the optimum stroke conditions in the test fixture, various installation heights can be achieved by combining test probes and receptacles











General data

ICT / FCT (in-circuit test and function test Product group: Sub-product group: Standard stroke test probe Series: GKS-075 1.91 mm [75.1 mil] Grid: Contacting from: Post Magnetic: Yes Installation type: Plug-in Quick-exchange system: Yes Adjustable installation height: No Non-rotating: No Compatible receptacle(s): KS-075 Min. temperature: -40 °C [-40 °F] 80 °C [176 °F] Max. temperature: RoHS-compliant:

Tip style data

Tip style: 19 90° inverse cone, slotted, self cleaning Tip diameter: 1.2 mm [.047 in] Tip style surface: A gold 3 CuBe Tip style material:

Electrical data

Current load capacity / rated current: 3 A Typical resistance (Ri): 20 mOhm

Mechanical data

Yes

Total length: 33.1 mm [1.3 in] Barrel diameter: 1.02 mm [.04 in] Maximum stroke: 6.35 mm [.25 in] Spring pre-load: 0.6 N [2.15 ozf] Collar height: Spring force at working stroke: 1.5 N [5.39 ozf] Recommended working stroke: 4.3 mm [.169 in]

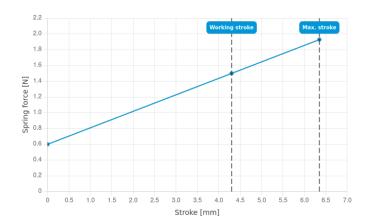
Partner for Future Technology

Test Probe

GKS-075 319 120 A 1500

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